

Notice of References Cited	Application/Control No. 09/934,891	Applicant(s)/Patent Under Reexamination KU, JOSEPH WEIYEH	
	Examiner Dipakkumar Gandhi	Art Unit 2133	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0103619 A1	08-2002	Bizjak, Karl M.	702/180
	B	US-5,519,389	05-1996	DeGunther et al.	340/870.29
	C	US-4,519,090	05-1985	Stackhouse et al.	377/29
	D	US-4,202,019	05-1980	Popoff et al.	360/51
	E	US-6,600,328 B2	07-2003	Ku, Joseph Weiyeh	324/678
	F	US-3,882,492	05-1975	McSorley et al.	340/518
	G	US-4,531,102	07-1985	Whitlock et al.	331/1A
	H	US-3,801,834	04-1974	Lai, Chi Sun	327/176
	I	US-4,339,759	07-1982	Nakatsu, Kanji	346/33R
	J	US-6,516,384 B1	02-2003	Clark et al.	711/109
	K	US-6,034,738	03-2000	Sparks, Bradley Alan	348/564
	L	US-6,499,656 B1	12-2002	Marsh et al.	235/375
	M	US-4,320,962	03-1982	Takahashi et al.	345/634

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.